## **Power MOSFET**

# 30 V, 2.5 A, Single N–Channel, SOT–23 Features

- Leading Planar Technology for Low Gate Charge / Fast Switching
- 4.5 V Rated for Low Voltage Gate Drive
- SOT-23 Surface Mount for Small Footprint (3 x 3 mm)
- Pb–Free Package is Available

## Applications

- DC–DC Conversion
- Load/Power Switch for Portables
- Load/Power Switch for Computing

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parame	eter		Symbol	Value	Unit
			-		
Drain-to-Source Voltage	V <sub>DSS</sub>	30	V		
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain	Steady	$T_A = 25^{\circ}C$	I <sub>D</sub>	2.0	А
Current (Note 1)	State	$T_A = 85^{\circ}C$		1.5	
	$t \le 10 s$	$T_A = 25^{\circ}C$		2.5	
Power Dissipation (Note 1)	Steady State	$T_A = 25^{\circ}C$	P <sub>D</sub>	0.73	W
Continuous Drain	Steady	$T_A = 25^{\circ}C$	I <sub>D</sub>	1.5	А
Current (Note 2)	State	$T_A = 85^{\circ}C$		1.1	
Power Dissipation (Note 2)		$T_A = 25^{\circ}C$	PD	0.42	W
Pulsed Drain Current	t <sub>p</sub> =	₌ 10 μs	I <sub>DM</sub>	6.0	А
ESD Capability (Note 3)	C = 100 pF, RS = 1500 Ω		ESD	125	V
Operating Junction and Storage Temperature		T <sub>J</sub> , T <sub>stg</sub>	–55 to 150	°C	
Source Current (Body Diode)			۱ <sub>S</sub>	2.0	А
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\thetaJA}$	170	°C/W
Junction-to-Ambient - t < 10 s (Note 1)	$R_{\thetaJA}$	100	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	300	

1. Surface-mounted on FR4 board using 1 in sq pad size.

2. Surface-mounted on FR4 board using the minimum recommended pad size.

3. ESD Rating Information: HBM Class 0.

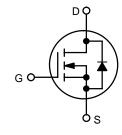


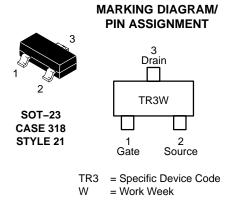
## ON Semiconductor®

#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> TYP	I <sub>D</sub> MAX
30 V	85 mΩ @ 10 V	2.5 A
00 1	105 mΩ @ 4.5 V	2.073







#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTR4503NT1	SOT-23	3000/Tape & Reel
NTR4503NT1G	SOT–23 (Pb–Free)	3000/Tape & Reel
NTR4503NT3G	SOT-23 (Pb-Free)	10000/Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

This datasheet has been downloaded from http://www.digchip.com at this page

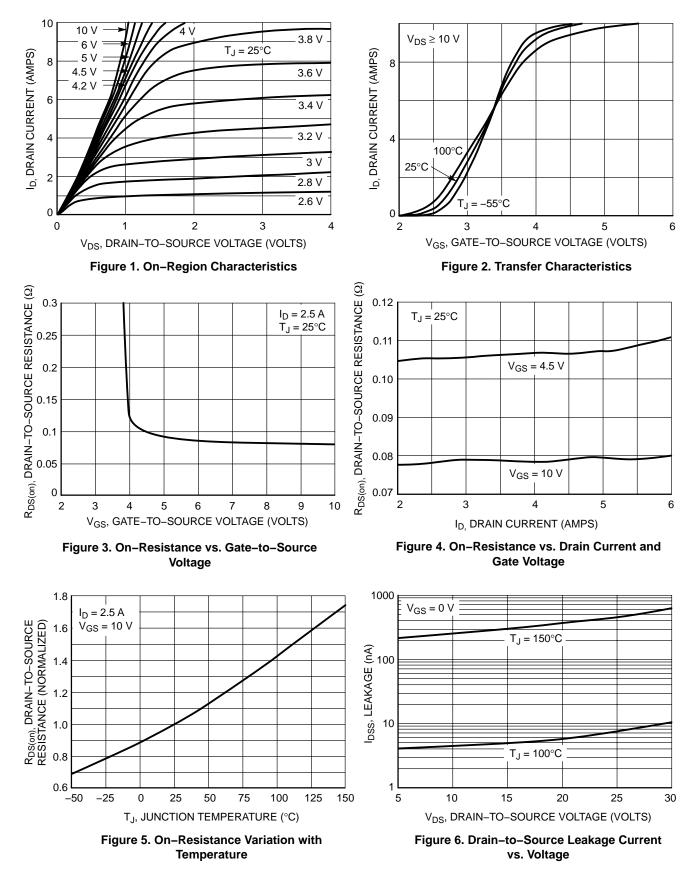
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## ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)

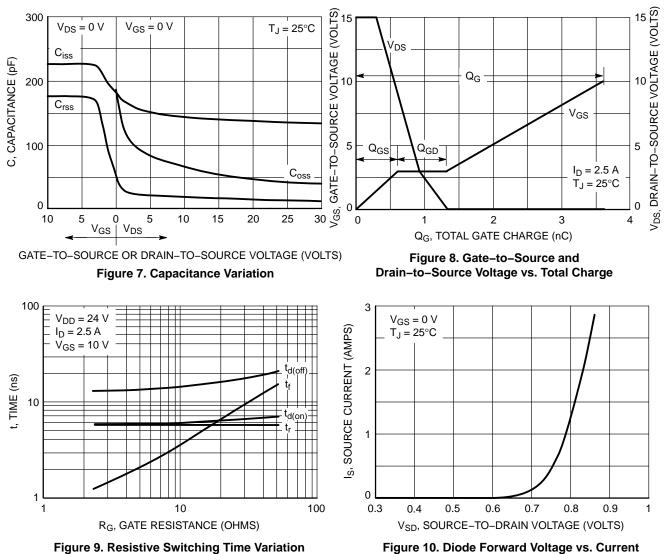
Parameter	Symbol	Test Conditions	Min	Тур	Max	Units
OFF CHARACTERISTICS	•	•				
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> = 250 $\mu$ A	30	36		V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V, V_{DS} = 24 V$			1.0	μΑ
		$V_{GS} = 0 \text{ V}, V_{DS} = 24 \text{ V}, T_{J} = 125^{\circ}\text{C}$			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS}$ = 0 V, $V_{GS}$ = ±20 V			±100	nA
ON CHARACTERISTICS (Note 4)	•			•		
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$	1.0	1.75	3.0	V
Drain-to-Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 2.5 A		85	110	mΩ
		$V_{GS} = 4.5 \text{ V}, I_D = 2.0 \text{ A}$		105	140	
Forward Transconductance	9fs	$V_{DS} = 4.5 \text{ V}, I_{D} = 2.5 \text{ A}$		5.3		S
CHARGES AND CAPACITANCES	•	•				
Input Capacitance	C <sub>iss</sub>			135		pF
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 15 V		52		1
Reverse Transfer Capacitance	C <sub>rss</sub>	• • • • • • • • • • • • • • • • • • •		15		
Input Capacitance	C <sub>iss</sub>			130	250	pF
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 24 V		42	75	
Reverse Transfer Capacitance	C <sub>rss</sub>	• DS = 24 •		13	25	
Total Gate Charge	Q <sub>G(TOT)</sub>			3.6	7.0	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	Vcs = 10 V. Vps = 15 V.		0.3		
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V},$ $I_D = 2.5 \text{ A}$		0.6		
Gate-to-Drain Charge	Q <sub>GD</sub>			0.7		
Total Gate Charge	Q <sub>G(TOT)</sub>			1.9		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	Vcs = 4.5 V. Vcs = 24 V.		0.3		
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 24 \text{ V},$ $I_D = 2.5 \text{ A}$		0.6		
Gate-to-Drain Charge	Q <sub>GD</sub>			0.9		
SWITCHING CHARACTERISTICS (No	ote 5)					
Turn–On Delay Time	t <sub>d(on)</sub>			5.8	12	ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>DD</sub> = 15 V,		5.8	10	
Turn–Off Delay Time	t <sub>d(off)</sub>	$I_D = 1 \text{ A}, \text{ R}_G = 6 \Omega$		14	25	
Fall Time	t <sub>f</sub>			1.6	5.0	
Turn–On Delay Time	t <sub>d(on)</sub>			4.8		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>DD</sub> = 24 V,		6.7		1
Turn–Off Delay Time	t <sub>d(off)</sub>	$I_{\rm D} = 2.5 \text{ A}, \text{ R}_{\rm G} = 2.5 \Omega$		13.6		
Fall Time	t <sub>f</sub>			1.8		
DRAIN-SOURCE DIODE CHARACTE	RISTICS					
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V, I_{S} = 2.0 A$		0.85	1.2	V
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 2.0 A,		9.2		ns
Reverse Recovery Charge	Q <sub>RR</sub>	$dI_{\rm S}/dt = 100 \text{ A}/\mu\text{s}$		4.0		nC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

## TYPICAL PERFORMANCE CURVES



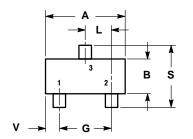
## **TYPICAL PERFORMANCE CURVES**

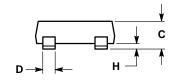


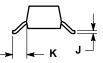
vs. Gate Resistance

## PACKAGE DIMENSIONS

SOT-23 (TO-236) CASE 318-09 **ISSUE AJ** 





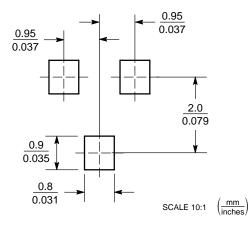


- NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH. 3. MAXIUMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL. 4. 318-01, -02, AND -06 OBSOLETE, NEW STANDARD 318-09.

	INCHES		MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.1102	0.1197	2.80	3.04
В	0.0472	0.0551	1.20	1.40
С	0.0385	0.0498	0.99	1.26
D	0.0140	0.0200	0.36	0.50
G	0.0670	0.0826	1.70	2.10
Н	0.0040	0.0098	0.10	0.25
J	0.0034	0.0070	0.085	0.177
K	0.0180	0.0236	0.45	0.60
L	0.0350	0.0401	0.89	1.02
S	0.0830	0.0984	2.10	2.50
v	0.0177	0.0236	0.45	0.60

STYLE 21: PIN 1. GATE 2. SOURCE 3. DRAIN

#### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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